

ID	R _{Ds} (ON)(Typ)	VDSS
105A	9.8mΩ	150V
• 100% a	: vitching speed avalanche tested ved dv/dt capability	

Ordering Information

Part Number	Package	Marking	Packing	Qty.
RS150N105S	T0-263	RS150N105S	Tape&reel	800 PCS

Absolute Maximun Ratings Tc= 25°C unless otherwise specified

Symbol	Parameter	RS150N105S	Units
VDSS	Drain-to-Source Voltage	150	V
ID	Continuous Drain Current TC=25℃	105	
ID	Continuous Drain Current TC=100°C	75	А
IDM	Pulsed Drain Current	420	
PD	Power Dissipation	380	W
VGS	Gate- to- Source Voltage	±20	V
EAS	Single Pulse Avalanche Engergy L = 0.3mH,VDS = 50V, RG = 25Ω, Tj = 25℃	1000	mJ
	Maximum Temperature for Soldering		
TL TPKG	Leads at 0.063in(1.6mm)from Case for 10 seconds Package Body for 10 seconds	300 260	°C
TJ and TSTG	Operating Junction and Storage Temperature Range	-55 to 150	

* Drain Current Limited by Maximum Junction Temperature

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" Table may cause permanent damage to the device.



Thermal Resistance

Symbol	Parameter	RS150N105S	Units	Test Conditions
RθJC	Junction-to-Case	0.36	°C/W	Drain lead soldered to water cooled heatsink, PD adjusted for a peak junction temperature of + 1 5 0 $^{\circ}$ C
RθJA	Junction-to- Ambient	60		1 cubic foot chamber,free air.

OFF Characteristics TJ= 25° C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions	
BVDSS	Drain- to- source Breakdown Voltage	150			V	VGS=0V,ID=250μ Α	
IDSS	Drain- to- Source Leakage Current			1	μA	VDS=150V,VGS= 0V	
	Gate- to- Source Forward Leakage			100	- 4	VGS=20V ,VDS=0 V	
IGSS	Gate- to- Source Reverse Leakage			-100	nA	VGS=-20V ,VDS= 0V	

ON Characteristics TJ=25°C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
RDS(on)	Static Drain- to- Source On- Resistance		9.8	11	mΩ	VGS=10V,ID=60A
VGS(TH)	Gate Threshold Voltage	3.6		5.0	V	VGS=VDS,ID=25 0μA

Resistive Switching Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
td(ON)	Turn- on Delay Time		45			
trise	Rise Time		70		6	VDS=50V ID=40A
td(OFF)	Turn- OFF Delay Time		110		nS	RG=2.5Ω VGS=10V
tfall	Fall Time		90			VG3-10V



Dynamic Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions	
Ciss	Input Capacitance		7000			VGS= 0V	
Coss	Output Capacitance		480		pF	VDS=50V	
Crss	Reverse Transfer Capacitance		210			f=1MHz	
Qg	Total Gate Charge		85			VDS= 100V	
Qgs	Gate- to- Source Charge		15		nC	ID=40A	
Qgd	Gate-to-Drain(" Miller") Charge		25			VGS=10V	

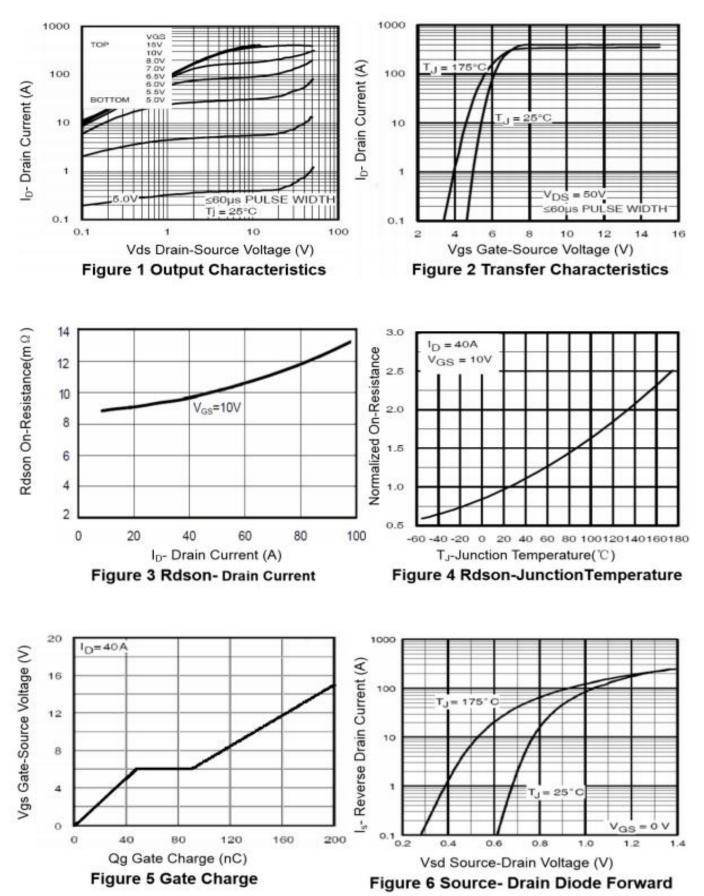
Source- Drain Diode Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
IS	Continuous Source Current			105	А	Integral pn- diode
ISM	Maximum Pulsed Current			420	А	in MOSFET
VSD	Diode Forward Voltage			1.2	V	IS=60A,VGS=0V
trr	Reverse Recovery Time		110		nS	VGS=0V
Qrr	Reverse Recovery Charge		0.55		μC	IS=30A di/dt=100A/μs

Notes:

- * 1. Repetitive rating, pulse width limited by maximum junction temperature.
- * 2. Pulse Test: Pulse width \leq 300µs, Duty Cycle \leq 1.5%

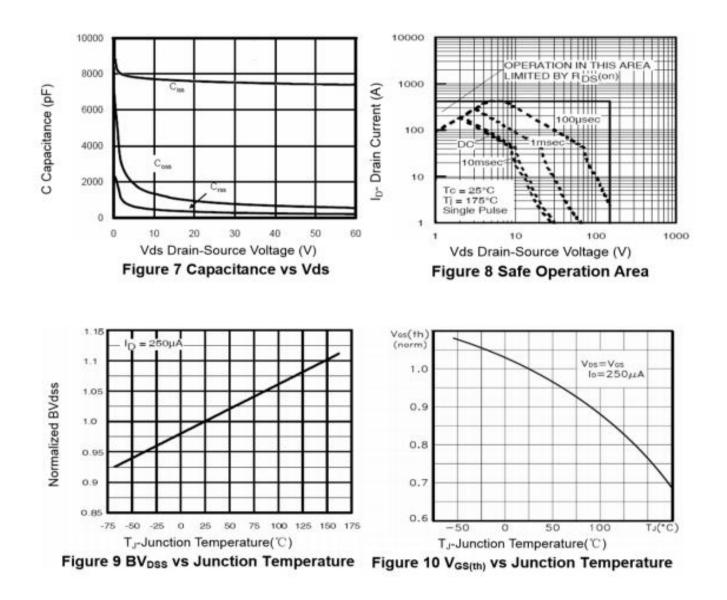


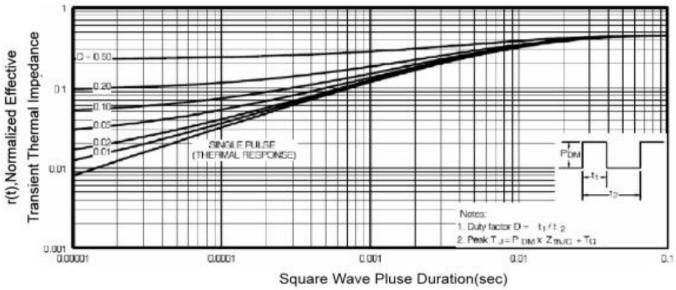


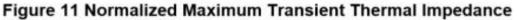
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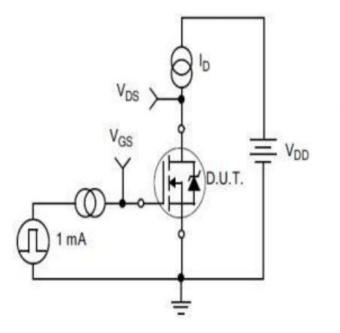




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Test ircuits and Waveforms



VGS(TH)

VDS

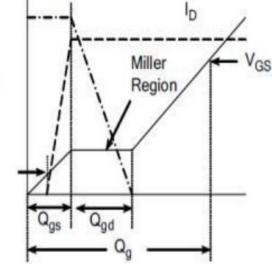


Figure A. Gate Charge Test Circuit

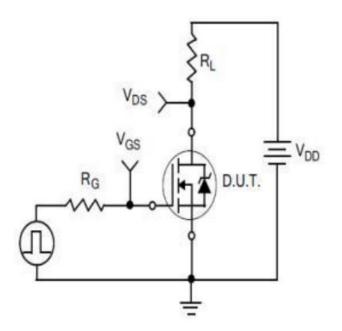


Figure C. Resistive Switching Test Circuit

Figure B. Gate Charge Waveform

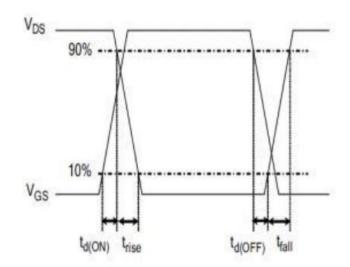
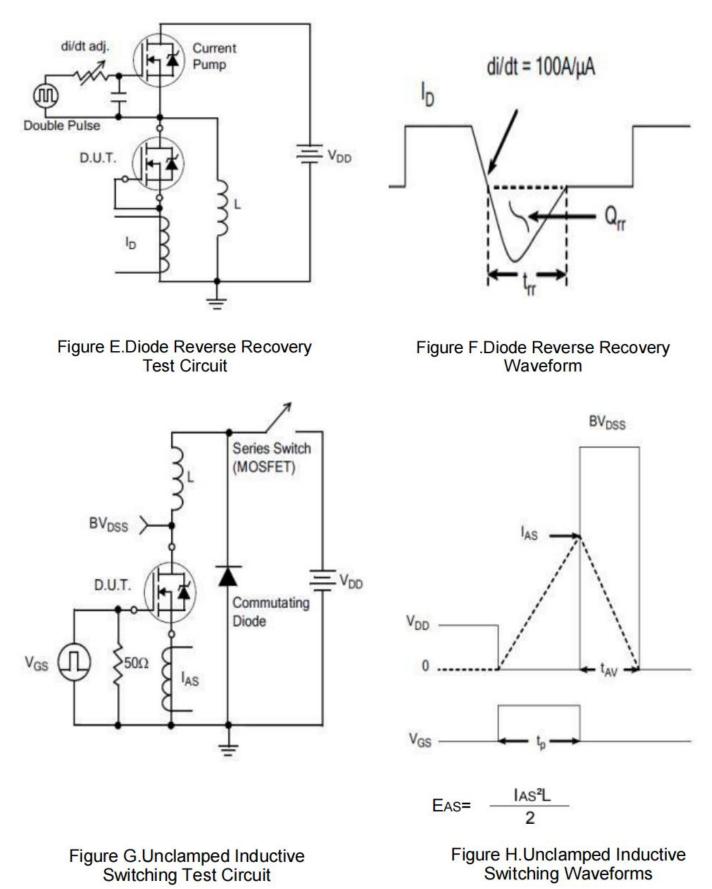


Figure D. Resistive Switching Waveforms

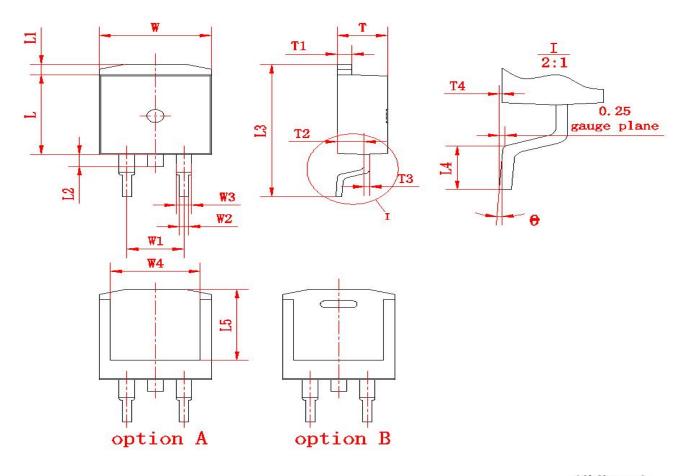


Test ircuits and Waveforms





Package outline drawing(TO-263 Unit: mm)



(单位: mm)

符号	尺寸		27	尺寸		符号	尺寸	
	Min	Max	符号	Min	Max	何ち	Min	Max
W	9.80	10.20	L1	1.00	1.40	T1	1.20	1.40
W1	(5.	08)	L2	1.20	1.60	T2	2.20	2.60
W2	0.70	0.95	L3	15.00	15. 60	Т3	0.45	0.65
W3	1.17	1. 62	L4	2.20	2.80	T4	0	0.25
W 4	(8)	. 0)	L5	(8.2)		θ	0°	8°
L	9.00	9.40	Т	4.30	4.70			



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